Power MOSFET

30 V, 6.7 A, Single N–Channel, ChipFET[™] Package

Features

- Planar Technology Device Offers Low R_{DS(on)} and Fast Switching Speed in a ChipFET Package
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP–6. Ideal Device for Applications Where Board Space is at a Premium.
- ChipFET Package Exhibits Excellent Thermal Capabilities Where Heat Transfer is Required.
- Pb–Free Package is Available

Applications

- Buck and Boost Converters
- Optimized for Battery and Load Management Applications in Portable Equipment such as Notebook Computers, MP3 Players, Cell Phones, Digital Cameras, Personal Digital Assistants and Other Portable Applications
- Charge Control in Battery Chargers

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	30	V		
Gate-to-Source Voltag	е		V _{GS}	±20	V
Continuous Drain	Steady $T_A = 25$		I _D	4.9	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		3.5	
	t ≤ 5 s	$T_A = 25^{\circ}C$		6.7	
Power Dissipation	Steady	$T_A = 25^{\circ}C$	PD	1.3	W
(Note 1)	State	$T_A = 85^{\circ}C$		0.7	
	t ≤ 5 s	$T_A = 25^{\circ}C$		2.5	
Pulsed Drain Current	t _p = 10 μ	เร	I _{DM}	20	А
Operating Junction and	T _J , T _{STG}	–55 to 150	°C		
Source Current (Body D	۱ _S	1.1	А		
Lead Temperature for S (1/8" from case for 1		urposes	ΤL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	R_{\thetaJA}	95	°C/W
Junction-to-Foot (Drain) Steady State (Note 1)	$R_{\theta JF}$	20	
Junction–to–Ambient – t \leq 5 s (Note 1)	$R_{\theta JA}$	50	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface Mounted on FR4 Board using 1 in sq. pad size

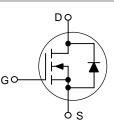
(Cu area = 1.127 in sq [1 oz] including traces).



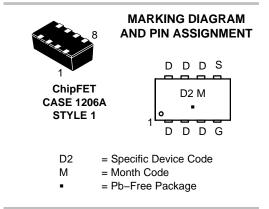
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} Typ	I _D Max
30 V	30 mΩ @ 10 V	6.7 A
00 1	40 mΩ @ 4.5 V	0.177



N-Channel MOSFET



ORDERING INFORMATION

Device	Package	Shipping [†]
NTHS4501NT1	ChipFET	3000/Tape & Reel
NTHS4501NT1G	ChipFET (Pb-Free)	3000/Tape & Reel

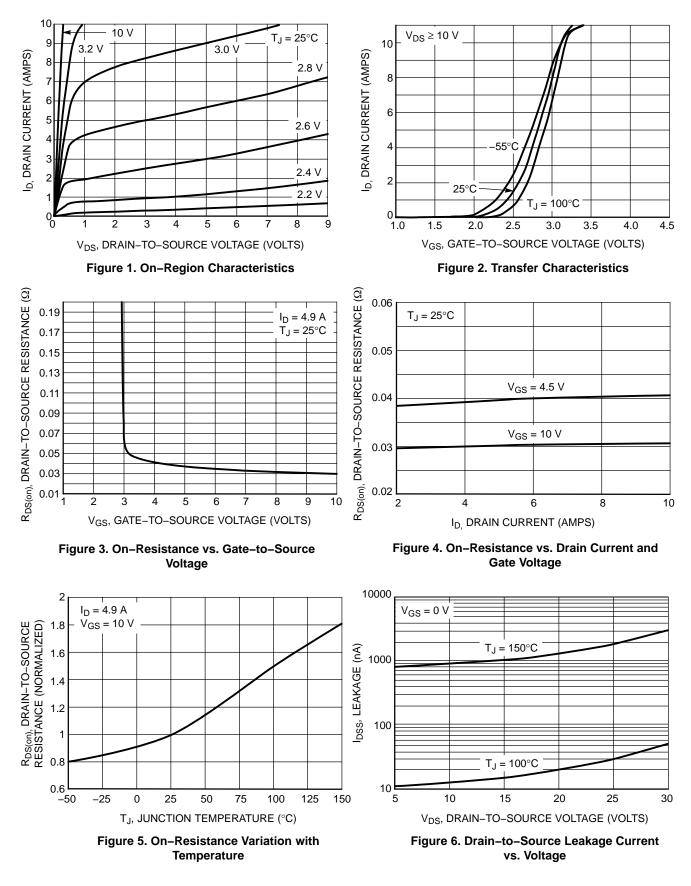
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

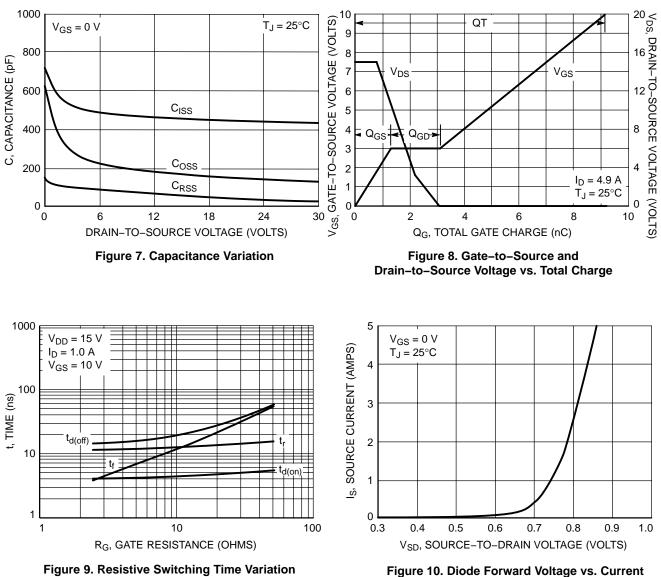
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D = 250 \mu A$		30	31		V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				30		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V, V_{DS} = 24 V$ $T_{J} = 25^{\circ}C$				1.0	μΑ
			$T_J = 125^{\circ}C$			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = 1$	±20 V			100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	50 μΑ	1.0	1.6	2.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V_{GS} = 10 V, I _D = 4.9 A V_{GS} = 4.5 V, I _D = 3.9 A			30	38	mΩ
					40	50	1
Forward Transconductance	9 _{FS}	V _{DS} = 10 V, I _D = 4.9 A			15		S
CHARGES AND CAPACITANCES	1						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 24 V			462		pF
Output Capacitance	C _{OSS}				137		
Reverse Transfer Capacitance	C _{RSS}				32		
Total Gate Charge	Q _{G(TOT)}				9.1		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} =	15 V,		0.7		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = I_D = 4.9 \text{ A}$,		1.3		
Gate-to-Drain Charge	Q _{GD}				1.8		
SWITCHING CHARACTERISTICS (No	te 3)				•		
Turn–On Delay Time	t _{d(on)}				4.0		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS} =	15 V,		11		
Turn–Off Delay Time	t _{d(off)}	$I_D = 1.0 \text{ A}, \text{ R}_G = 6$			17		1
Fall Time	t _f				7.5		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-	•	-
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, I_{S} = 1.1 A$	T _J = 25°C		0.75	1.2	V
Reverse Recovery Time	t _{RR}				19.1		ns
Charge Time	t _a	V _{GS} = 0 V, I _S = 1.	1 A,		11.9		
Discharge Time	t _b	$dI_S/dt = 90 A/\mu$			7.3		
Reverse Recovery Charge	Q _{RR}				13		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)





TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

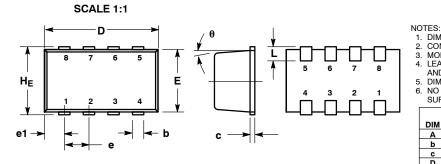
Figure 9. Resistive Switching Time Variation vs. Gate Resistance

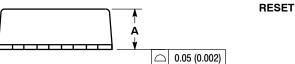
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ChipFET™ CASE1206A-03 **ISSUE K**

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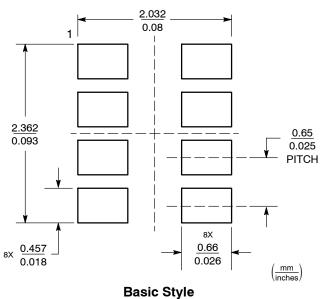
1.

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- 2.
- CONTROLLING DIMENSION: MILLINGTER.
 MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
 DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE. 6.

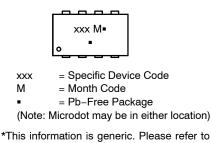
	MILLIMETERS				INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.65 BSC			0.025 BSC		
e1		0.55 BSC			0.022 BSC	;	
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ		5° NOM			5° NOM		

STYLE 1: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. GATE 5. SOURCE 6. DRAIN	STYLE 2: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6 DRAIN 2	STYLE 3: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN	STYLE 4: PIN 1. COLLECTOR 2. COLLECTOR 3. COLLECTOR 4. BASE 5. EMITTER 6. COLLECTOR	STYLE 5: PIN 1. ANODE 2. ANODE 3. DRAIN 4. DRAIN 5. SOURCE 6. CATE	STYLE 6: PIN 1. ANODE 2. DRAIN 3. DRAIN 4. GATE 5. SOURCE 6. DDAIN
5. SOURCE 6. DRAIN 7. DRAIN 8. DRAIN	5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	5. DHAIN 6. DRAIN 7. CATHODE 8. CATHODE	5. EMITTER 6. COLLECTOR 7. COLLECTOR 8. COLLECTOR	5. SOURCE 6. GATE 7. CATHODE 8. CATHODE	6. DRAIN 7. DRAIN

SOLDERING FOOTPRINT



GENERIC **MARKING DIAGRAM***



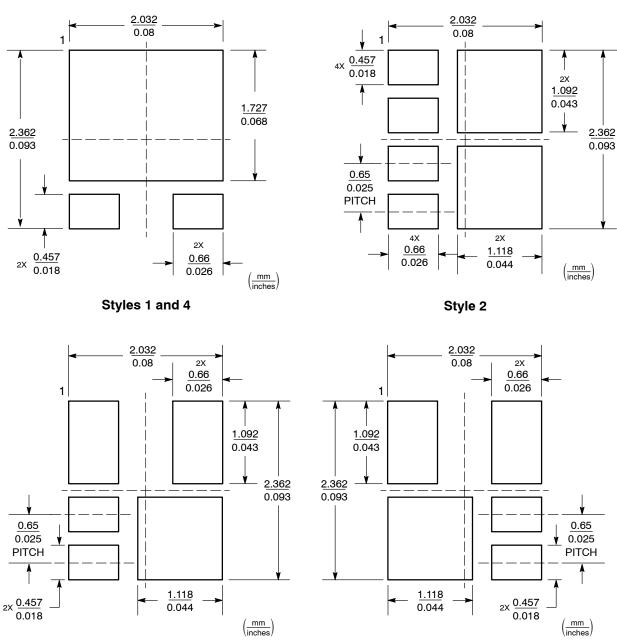
device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " .", may or may not be present.

OPTIONAL SOLDERING FOOTPRINTS ON PAGE 2

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ADDITIONAL SOLDERING FOOTPRINTS*

Style 3

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

Style 5

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